

Application/Control No.	Applicant(s)/Patent under Reexamination
09/924,054	SAITO, HIROYUKI
Examiner	Art Unit
John L. Shew	2664

	SEAR	CHED	
Class	Subclass	Date	Examiner
340	2.1,2.23	6/7/2005	JS
	2.24,3.1		
370	229,230.1	6/7/2005	JS
	232,233		,
	235,237		
	238,238.1		
	252,351		
	389,395.1		
	395.21		
	395.32		
	395.41		
	400,468		
	477,537		
	538,540		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	DATE	EXMR
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Search Notes (continued)

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	SEAR	CHED	_
Class	Subclass	Date	Examiner
709	220,221	6/7/2005	JS
	222,225		
	226,238		
	239		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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